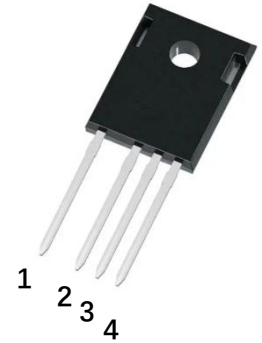


## 650V Planar SiC Power MOSFET

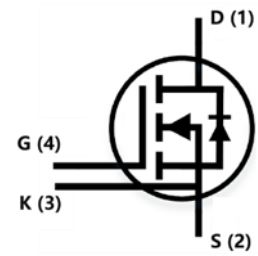
Parameter	Value	Unit
$V_{DS}$	650	V
$R_{DS(on\_typ.}$ $V_{GS}=15V$	90	m $\Omega$
$I_D$	36	A

### Features

- Wide Bandgap SiC MOSFET Technology
- Low On-Resistance with High Blocking Voltage
- Low Capacitances with High-Speed Switching
- Low Reverse Recovery (Qrr)
- Robust against Parasitic Turn on Even 0V Turn off Gate Voltage



TO-247-4L(A) TopView



Schematic Diagram

### Benefits

- Reduced Switching Losses
- Increased System Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements
- Reduced EMI

### Application

- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- Battery Chargers
- Motor Drives
- Pulsed Power Applications

### Package parameters

Part Number	Marking	Package	Packaging Method
GSW90R065MCL	GSW90R065MCL	TO-247-4L	TUBE

## Maximum ratings at $T_j=25^\circ\text{C}$ , Unless otherwise specified

Parameter	Symbol	Test Condition	Value	Unit
Drain to Source Voltage	$V_{DS}$	$V_{GS} = 0V, I_D = 100\mu\text{A}$	650	V
Gate to Source Voltage	$V_{GS}$	Absolute maximum values	-10/+22	V
Recommended Operation Voltage of Gate to Source	$V_{GSop}$	Recommended operational values	0/+18	V
Continuous Drain Current	$I_D$	$V_{GS}=15V, T_C=25^\circ\text{C}$	36	A
		$V_{GS}=15V, T_C=100^\circ\text{C}$	27	
Pulsed Drain Current	$I_{DM}$	$V_{GS}=15V, T_C=25^\circ\text{C}$	72	A
Power Dissipation	$P_{tot}$	$T_C=25^\circ\text{C}, T_j=175^\circ\text{C}$	136	W
Operating and Storage Temperature	$T_j, T_{stg}$		-55 to +175	$^\circ\text{C}$

## Thermal Characteristics

Parameter	Symbol	Value			Unit
		Min.	Typ.	Max.	
Thermal Resistance from Junction to Case	$R_{th(j-c)}$	-	1.1	-	$^\circ\text{C}/\text{W}$

## Electrical Characteristics

### Static Characteristics

Parameter	Symbol	Test Condition	Value			Unit
			Min.	Typ.	Max.	
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=500\mu\text{A}$	650			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D=7.5\text{mA}$	2.7		4.5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{GS}=0V, V_{DS}=650V, T_j=25^\circ\text{C}$			10	$\mu\text{A}$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS}=18V, V_{DS}=0V$			250	nA
Drain to Source on Resistance	$R_{DS(on)}$	$V_{GS}=15V, I_D=17A$		90	120	m $\Omega$
		$V_{GS}=15V, I_D=17A, T_j=175^\circ\text{C}$		75		
		$V_{GS}=18V, I_D=17A$		65		
		$V_{GS}=18V, I_D=17A, T_j=175^\circ\text{C}$		70		

## Dynamic Characteristics

Parameter	Symbol	Test Condition	Value			Unit
			Min.	Typ.	Max.	
Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=500V, f=100KHz,$ $T_j=25^{\circ}C$		1040		pF
Output Capacitance	$C_{oss}$			96		
Reverse Transfer Capacitance	$C_{rss}$			9		
Total Gate Charge	$Q_g$	$V_{GS}=0/15V, V_{DS}=500V, I_D=17A,$ $T_j=25^{\circ}C$		41		nC
Gate-Source Charge	$Q_{gs}$			10		
Gate-Drain Charge	$Q_{gd}$			16		
Gate Resistance	$R_g$	$V_{AC}=25mV, f=100KHz$		2.85		$\Omega$

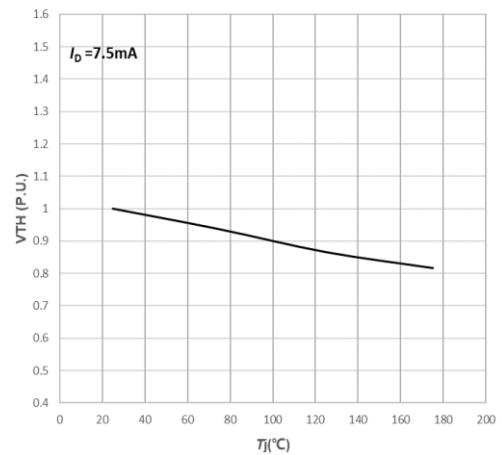
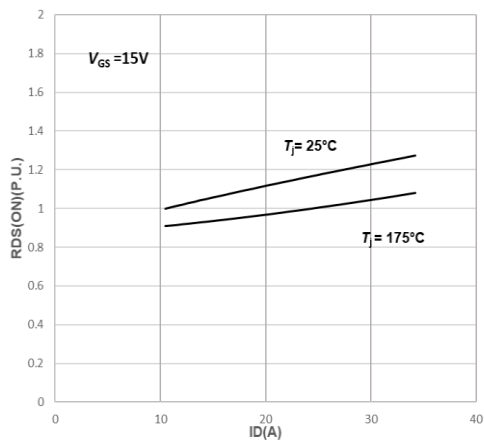
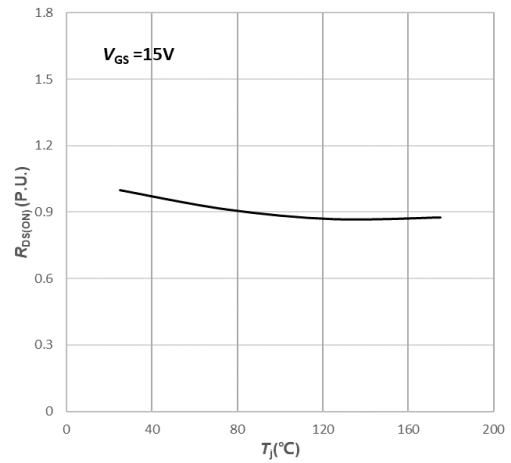
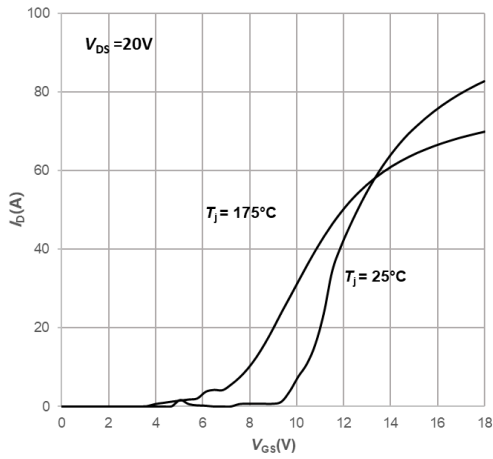
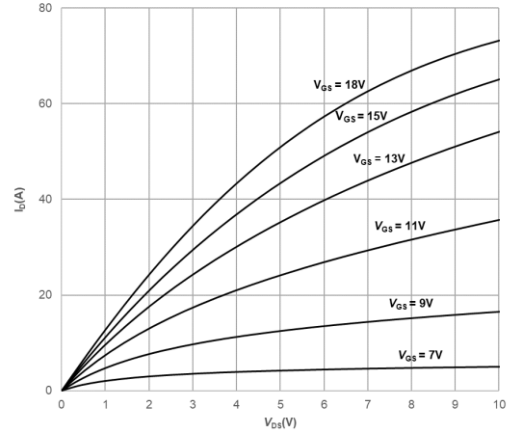
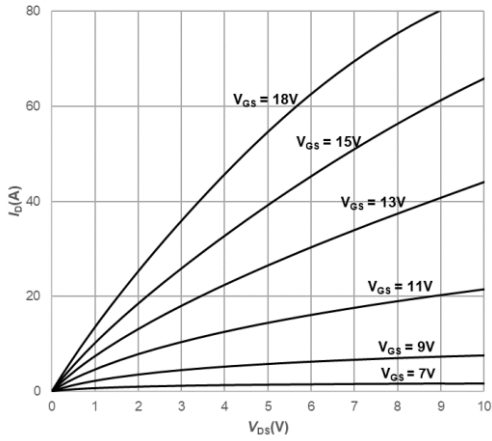
## Switching Characteristics

Parameter	Symbol	Test Condition	Value			Unit
			Min.	Typ.	Max.	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS}=0/15V, V_{DD}=500V,$ $I_D=17A, R_g=2\Omega$		19		ns
Rise Time	$t_r$			115		
Turn-Off Delay Time	$t_{d(off)}$			31		
Fall Time	$t_f$			34		

## Reverse Diode Characteristics

Parameter	Symbol	Test Condition	Value			Unit
			Min.	Typ.	Max.	
Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_{SD}=8.5A, T_j=25^{\circ}C$		3.5		V
Continuous Diode Forward Current	$I_S$	$V_{GS}=0V, T_j=25^{\circ}C$		36		A
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0V, I_{SD}=17A,$ $V_R=500V, di/dt=550A/us, T_j=25^{\circ}C$		17.8		ns
Reverse Recovery Charge	$Q_{rr}$			63		nC
Peak Reverse Recovery Current	$I_{rrm}$			4.9		A

## Typical Performance



## Typical Performance

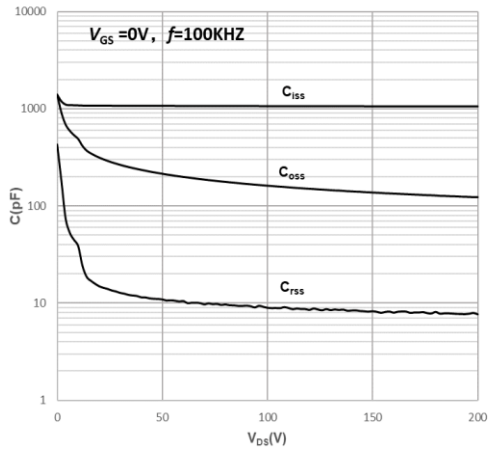


Fig7. Capacitances vs. Drain-Source Voltage (0-200V)

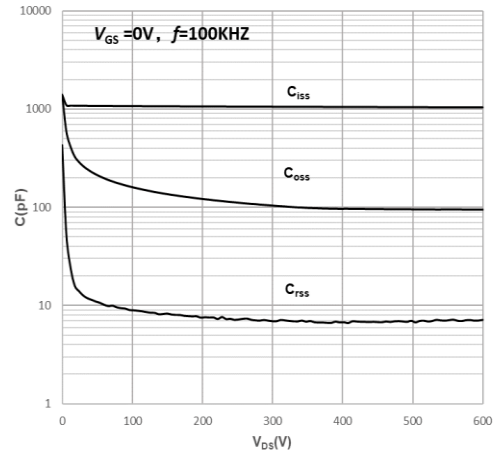


Fig8. Capacitances vs. Drain-Source Voltage (0-600V)

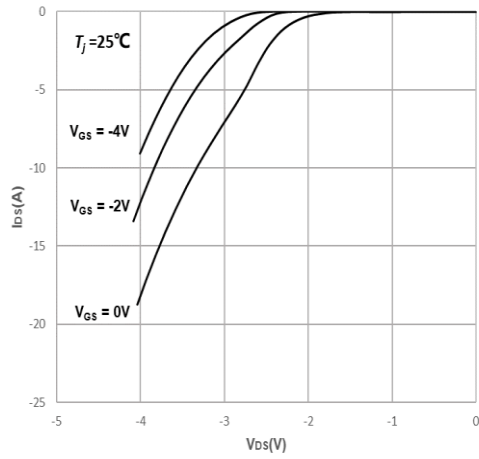
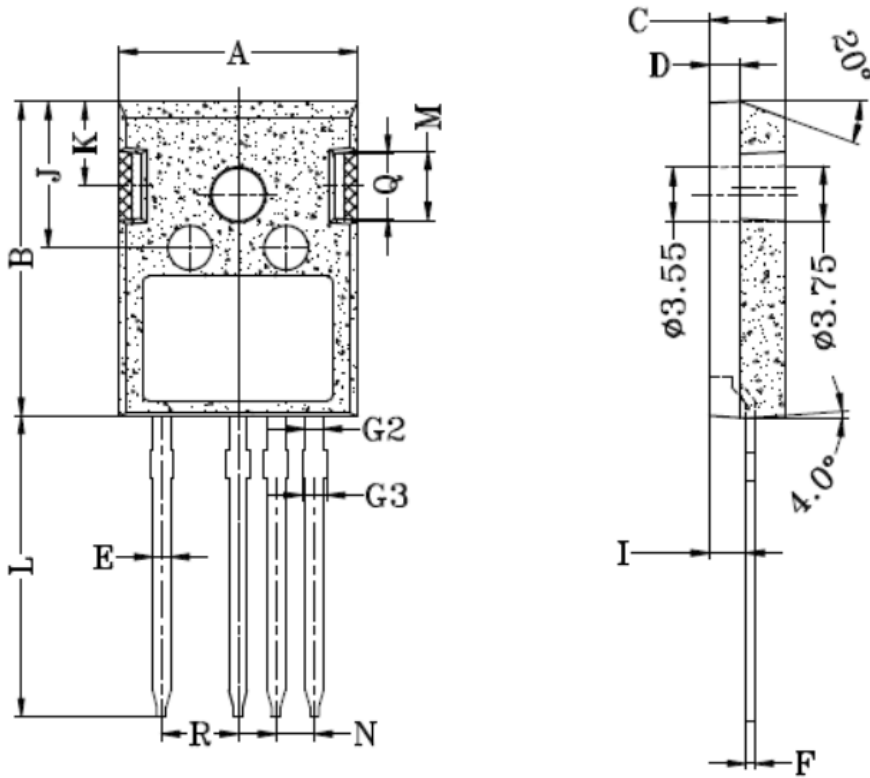
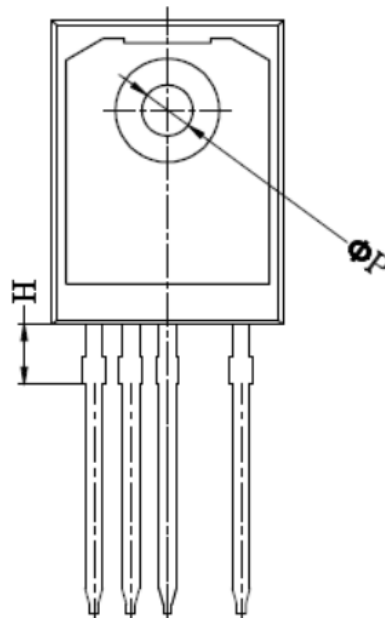


Fig9. Body Diode Characteristics

## TO-247-4L(A) Package Dimensions



Symbol	Dimensions in Millimeter	
	MIN	MAX
A	15.80	16.00
B	20.90	21.10
C	4.90	5.10
D	1.90	2.10
E	1.10	1.30
F	0.50	0.70
G2	1.10	1.30
G3	1.18	1.38
H	4.18	4.38
I	2.30	2.50
J	9.65	9.85
K	5.54	5.74
L	19.80	20.20
M	4.50	4.70
N	2.34	2.74
φ P	3.40	3.60
Q	4.232	4.432
R	4.88	5.28



## Disclaimer

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## Reversion History

Rev.	Date	Change Description
1.0	2025-07-20	Form the initial version
1.1	2025-08-15	Update electrical parameter